

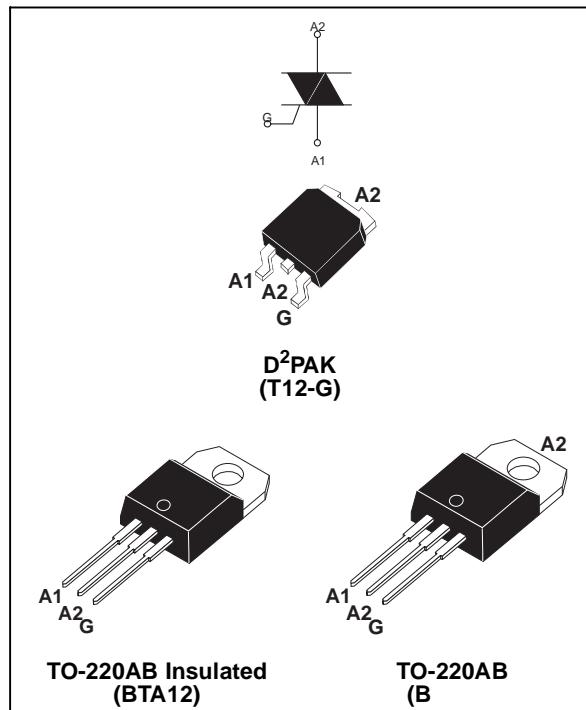
**MAIN FEATURES:**

Symbol	Value	Unit
$I_T(\text{RMS})$	12	A
$V_{\text{DRM}}/V_{\text{RRM}}$	600 and 800	V
$I_{\text{GT}}(Q_1)$	5 to 50	mA

**DESCRIPTION**

Available either in through-hole or surface-mount packages, the BTA/BTB12 and T12 triac series is suitable for general purpose AC switching. They can be used as an ON/OFF function in applications such as static relays, heating regulation, induction motor starting circuits... or for phase control operation in light dimmers, motor speed controllers,...

The snubberless versions (BTA/BTB...W and T12 series) are specially recommended for use on inductive loads, thanks to their high commutation performances. Logic level versions are designed to interface directly with low power drivers such as microcontrollers. By using an internal ceramic pad, the BTA series provides voltage insulated tab (rated at 2500V RMS) complying with UL standards (File ref.: E81734)


**ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter			Value	Unit
$I_T(\text{RMS})$	RMS on-state current (full sine wave)		D²PAK/TO-220AB	12	A
	TO-220AB Ins.		Tc = 90°C		
$I_{TSM}$	Non repetitive surge peak on-state current (full cycle, Tj initial = 25°C)		F = 50 Hz	120	A
	F = 60 Hz		t = 20 ms		
$I^2t$	F = 60 Hz		t = 16.7 ms	126	A
	I <sup>2</sup> t Value for fusing		tp = 10 ms		
$dl/dt$	tp = 10 ms		78	A <sup>2</sup> s	
	Critical rate of rise of on-state current $I_G = 2 \times I_{\text{GT}}$ , tr ≤ 100 ns		F = 120 Hz		
$V_{\text{DSM}}/V_{\text{RSM}}$	Tj = 125°C		50	A/μs	
	Tj = 25°C		V <sub>DRM</sub> /V <sub>RRM</sub> + 100		
$I_{\text{GM}}$	V		4	A	
	Tj = 125°C		1		
$P_{\text{G(AV)}}$	Average gate power dissipation		Tj = 125°C	W	
	- 40 to + 150		- 40 to + 125		
$T_{\text{stg}}$ $T_j$	°C			°C	
	Operating junction temperature range				

**ELECTRICAL CHARACTERISTICS (T<sub>j</sub> = 25°C, unless otherwise specified)**
**■ SNUBBERLESS™ and LOGIC LEVEL (3 Quadrants)**

Symbol	Test Conditions	Quadrant	T12		BTA/BTB12			Unit	
			T1235	TW	SW	CW	BW		
I <sub>GT</sub> (1)	V <sub>D</sub> = 12 V R <sub>L</sub> = 30 Ω	I - II - III	MAX.	35	5	10	35	50	mA
V <sub>GT</sub>		I - II - III	MAX.			1.3			V
V <sub>GD</sub>	V <sub>D</sub> = V <sub>DRM</sub> R <sub>L</sub> = 3.3 kΩ T <sub>j</sub> = 125°C	I - II - III	MIN.			0.2			V
I <sub>H</sub> (2)	I <sub>T</sub> = 100 mA		MAX.	35	10	15	35	50	mA
I <sub>L</sub>	I <sub>G</sub> = 1.2 I <sub>GT</sub>	I - III	MAX.	50	10	25	50	70	mA
		II		60	15	30	60	80	
dV/dt (2)	V <sub>D</sub> = 67 %V <sub>DRM</sub> gate open T <sub>j</sub> = 125°C		MIN.	500	20	40	500	1000	V/μs
(dI/dt)c (2)	(dV/dt)c = 0.1 V/μs T <sub>j</sub> = 125°C		MIN.	-	3.5	6.5	-	-	A/ms
	(dV/dt)c = 10 V/μs T <sub>j</sub> = 125°C			-	1	2.9	-	-	
	Without snubber T <sub>j</sub> = 125°C			6.5	-	-	6.5	12	

**■ STANDARD (4 Quadrants)**

Symbol	Test Conditions	Quadrant		BTA/BTB12		Unit
				C	B	
I <sub>GT</sub> (1)	V <sub>D</sub> = 12 V R <sub>L</sub> = 30 Ω	I - II - III IV	MAX.	25	50	mA
V <sub>GT</sub>		ALL		50	100	
V <sub>GD</sub>	V <sub>D</sub> = V <sub>DRM</sub> R <sub>L</sub> = 3.3 kΩ T <sub>j</sub> = 125°C	ALL	MIN.		0.2	V
I <sub>H</sub> (2)	I <sub>T</sub> = 500 mA		MAX.	25	50	mA
I <sub>L</sub>	I <sub>G</sub> = 1.2 I <sub>GT</sub>	I - III - IV	MAX.	40	50	mA
		II		80	100	
dV/dt (2)	V <sub>D</sub> = 67 %V <sub>DRM</sub> gate open T <sub>j</sub> = 125°C		MIN.	200	400	V/μs
(dV/dt)c (2)	(dI/dt)c = 5.3 A/ms T <sub>j</sub> = 125°C		MIN.	5	10	V/μs

**STATIC CHARACTERISTICS**

Symbol	Test Conditions			Value	Unit
V <sub>T</sub> (2)	I <sub>TM</sub> = 17 A tp = 380 μs	T <sub>j</sub> = 25°C	MAX.	1.55	V
V <sub>to</sub> (2)	Threshold voltage	T <sub>j</sub> = 125°C	MAX.	0.85	V
R <sub>d</sub> (2)	Dynamic resistance	T <sub>j</sub> = 125°C	MAX.	35	mΩ
I <sub>DRM</sub>	V <sub>DRM</sub> = V <sub>RRM</sub>	T <sub>j</sub> = 25°C	MAX.	5	μA
		T <sub>j</sub> = 125°C		1	mA

Note 1: minimum IGT is guaranteed at 5% of IGT max.

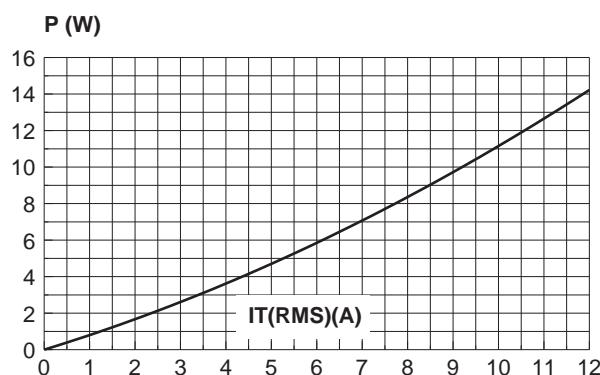
Note 2: for both polarities of A2 referenced to A1

**OTHER INFORMATION**

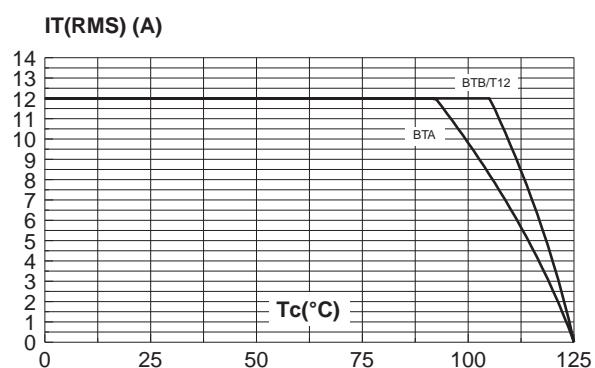
Part Number	Marking	Weight	Base quantity	Packing mode
BTA/BTB12-xxxyz	BTA/BTB12-xxxyz	2.3 g	250	Bulk
BTA/BTB12-xxxyzRG	BTA/BTB12-xxxyz	2.3 g	50	Tube
T1235-xxxG	T1235xxxG	1.5 g	50	Tube
T1235-xxxG-TR	T1235xxxG	1.5 g	1000	Tape & reel

Note: xxx = voltage, yy = sensitivity, z = type

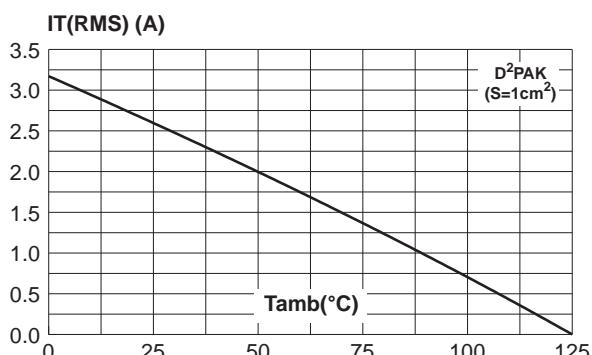
**Fig. 1:** Maximum power dissipation versus RMS on-state current (full cycle).



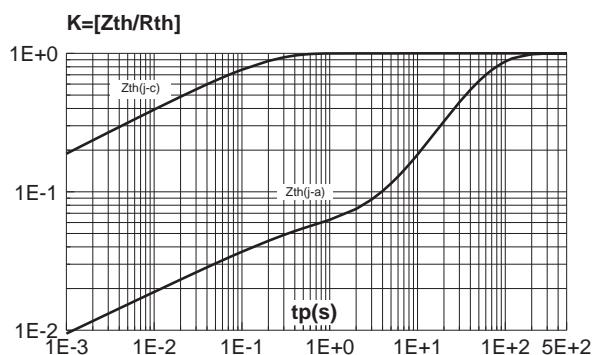
**Fig. 2-1:** RMS on-state current versus case temperature (full cycle).



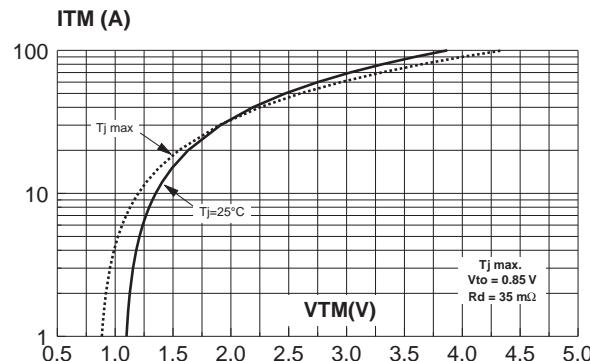
**Fig. 2-2:** RMS on-state current versus ambient temperature (printed circuit board FR4, copper thickness: 35µm), full cycle.



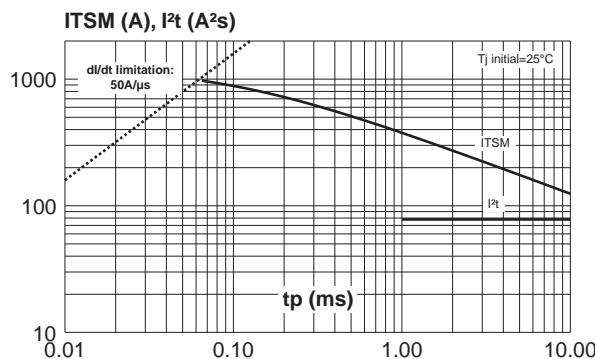
**Fig. 3:** Relative variation of thermal impedance versus pulse duration.



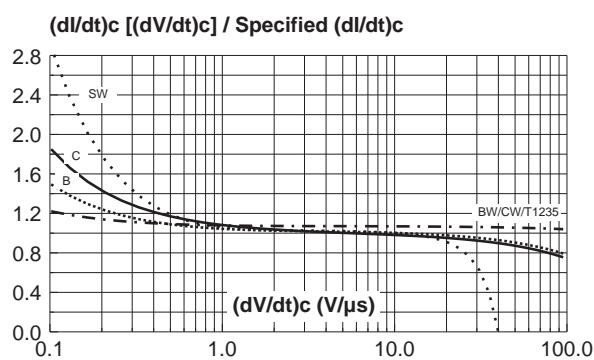
**Fig. 4:** On-state characteristics (maximum values).



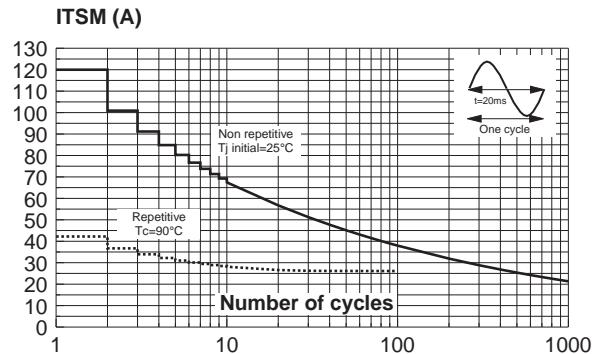
**Fig. 6:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$ , and corresponding value of  $I^2t$ .



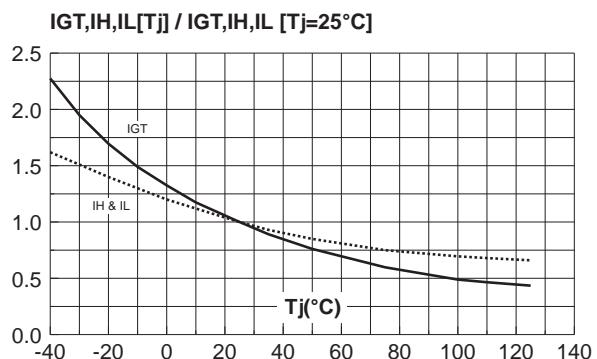
**Fig. 8-1:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)_c$  (typical values) (BW/CW/T1235).



**Fig. 5:** Surge peak on-state current versus number of cycles.



**Fig. 7:** Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values).



**Fig. 8-2:** Relative variation of critical rate of decrease of main current versus  $(dV/dt)_c$  (typical values) (TW).

